TEXAS INSTRUMENTS

CSD87333Q3D

SLPS350A –FEBRUARY 2014–REVISED JANUARY 2017

CSD87333Q3D Synchronous Buck NexFET™ Power Block

1 Features

- Half-Bridge Power Block
- Optimized for High-Duty Cycle
- Up to 24 V_{in}
- 94.7% System Efficiency at 8 A
- 1.5 W P_{Loss} at 8 A
- Up to 15-A Operation
- High-Frequency Operation (up to 1.5 MHz)
- High-Density SON 3.3-mm × 3.3-mm Footprint
- Optimized for 5-V Gate Drive
- Low-Switching Losses
- Ultra-Low Inductance Package
- RoHS Compliant
- Halogen Free
- Lead-Free Terminal Plating

2 Applications

- Synchronous Buck Converters
  - High-Frequency Applications
  - High-Duty Cycle Applications
- Synchronous Boost Converters
- POL DC-DC Converters

3 Description

The CSD87333Q3D NexFET™ power block is an optimized design for synchronous buck and boost applications offering high-current, high-efficiency, and high-frequency capability in a small 3.3-mm × 3.3-mm outline. Optimized for 5-V gate drive applications, this product offers a flexible solution in high-duty cycle applications when paired with an external controller or driver.
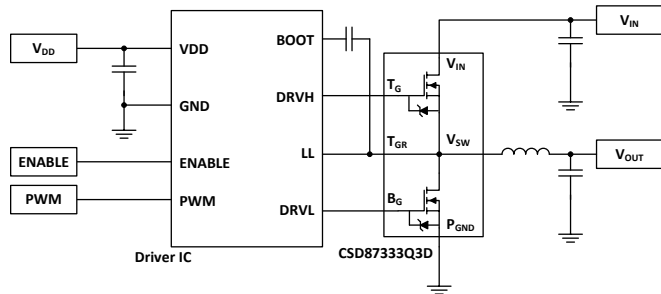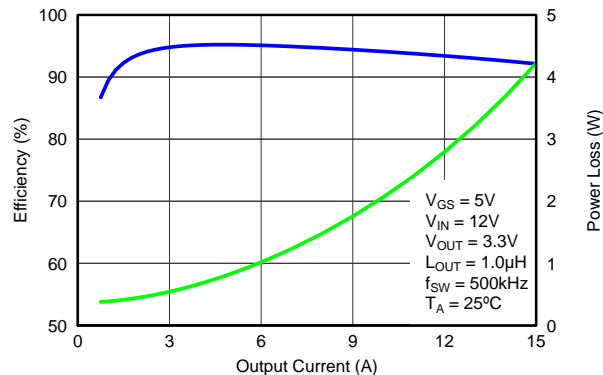
Top View
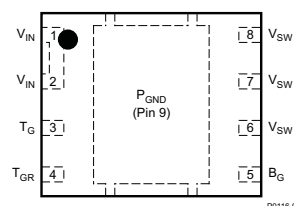
Device Information[1]

DEVICE	MEDIA	QTY	PACKAGE	SHIP
CSD87333Q3D	13-Inch Reel	2500	SON 3.30-mm × 3.30-mm Plastic Package	Tape and Reel
CSD87333Q3DT	7-Inch Reel	250		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Typical Circuit

Typical Power Block Efficiency and Power Loss

V_{GS} = 5V
V_{IN} = 12V
V_{OUT} = 3.3V
L_{OUT} = 1.0µH
f_{SW} = 500kHz
T_A = 25ºC

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4 Revision History

Changes from Original (February 2014) to Revision A   **Page**

- Added pulse duration note to I_{DM} in the *Absolute Maximum Ratings* table 3
- Added *Receiving Notification of Documentation Updates* section and *Community Resources* section to the *Device and Documentation Support* section 13

5 Specifications

5.1 Absolute Maximum Ratings[1]

T_A = 25°C (unless otherwise noted)

PARAMETER	CONDITIONS	MIN	MAX	UNIT
Voltage	V_{IN} to P_{GND}	−0.8	30	V
	V_{SW} to P_{GND}		30	V
	V_{SW} to P_{GND} (10 ns)		32	V
	T_G to T_{GR}	−0.3	10	V
	B_G to P_{GND}	−0.3	10	V
Pulsed current rating, I_{DM}[2]			40	A
Power dissipation, P_D			6	W
Avalanche energy, E_{AS}	Sync FET, I_D = 19, L = 0.1 mH		18	mJ
	Control FET, I_D = 19, L = 0.1 mH		18	
Operating junction temperature, T_J		−55	150	°C
Storage temperature, T_{stg}		−55	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) Pulse duration ≤ 50 µS. Duty cycle ≤ 0.01%.

5.2 Recommended Operating Conditions

T_A = 25°C (unless otherwise noted)

PARAMETER		CONDITIONS	MIN	MAX	UNIT
V_{GS}	Gate drive voltage		3.3	8	V
V_{IN}	Input supply voltage			24	V
f_{SW}	Switching frequency	C_{BST} = 0.1 µF (min)		1500	kHz
	Operating current			15	A
T_J	Operating temperature			125	°C

5.3 Power Block Performance[1]

T_A = 25°C (unless otherwise noted)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
P_{LOSS}	Power loss[1]	V_{IN} = 12 V, V_{GS} = 5 V, V_{OUT} = 3.3 V, I_{OUT} = 8 A, f_{SW} = 500 kHz, L_{OUT} = 1 µH, T_J = 25°C		1.5		W
I_{QVIN}	V_{IN} quiescent current	T_G to T_{GR} = 0 V B_G to P_{GND} = 0 V		10		µA

(1) Measurement made with six 10-µF (TDK C3216X5R1C106KT or equivalent) ceramic capacitors placed across V_{IN} to P_{GND} pins and using a high current 5-V driver IC.

## 5.4 Thermal Information

T_A = 25°C (unless otherwise stated)

THERMAL METRIC		MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance (min Cu)[1]			150	°C/W
	Junction-to-ambient thermal resistance (max Cu)[1][2]			80	
$R_{\theta JC}$	Junction-to-case thermal resistance (top of package)[1]			36	°C/W
	Junction-to-case thermal resistance (P_{GND} pin)[1]			3.7	

(1) $R_{\theta JC}$ is determined with the device mounted on a 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu pad on a 1.5-in × 1.5-in (3.81-cm × 3.81-cm), 0.06-in (1.52-mm) thick FR4 board. $R_{\theta JC}$ is specified by design while $R_{\theta JA}$ is determined by the user's board design.
(2) Device mounted on FR4 material with 1-in² (6.45-cm²) Cu.

Product Folder Links: *CSD87333Q3D*

5.5 Electrical Characteristics

$T_A = 25°C$ (unless otherwise stated)

PARAMETER		TEST CONDITIONS	Q1 Control FET			Q2 Sync FET			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
STATIC CHARACTERISTICS									
BV_{DSS}	Drain-to-source voltage	$V_{GS} = 0$ V, $I_{DS} = 250$ µA	30			30			V
I_{DSS}	Drain-to-source leakage current	$V_{GS} = 0$ V, $V_{DS} = 20$ V			1			1	µA
I_{GSS}	Gate-to-source leakage current	$V_{DS} = 0$ V, $V_{GS} = +10 / -8$ V			100			100	nA
$V_{GS(th)}$	Gate-to-source threshold voltage	$V_{DS} = V_{GS}$, $I_{DS} = 250$ µA	0.75	0.95	1.20	0.75	0.95	1.20	V
$R_{DS(on)}$	Drain-to-source on resistance	$V_{GS} = 3.5$ V, $I_{DS} = 4$ A		14.7	17.7		14.7	17.7	mΩ
		$V_{GS} = 4.5$ V, $I_{DS} = 4$ A		13.4	16.1		13.4	16.1	
		$V_{GS} = 8$ V, $I_{DS} = 4$ A		11.9	14.3		11.9	14.3	
g_{fs}	Transconductance	$V_{DS} = 15$ V, $I_{DS} = 4$ A		43			43		S
DYNAMIC CHARACTERISTICS									
C_{ISS}	Input capacitance	$V_{GS} = 0$ V, $V_{DS} = 15$ V, $f = 1$ MHz		509	662		509	662	pF
C_{OSS}	Output capacitance			222	289		222	289	pF
C_{RSS}	Reverse transfer capacitance			8.2	10.7		8.2	10.7	pF
R_G	Series gate resistance			3.4	6.8		3.4	6.8	Ω
Q_g	Gate charge total (4.5 V)	$V_{DS} = 15$ V, $I_{DS} = 4$ A		3.5	4.6		3.5	4.6	nC
Q_{gd}	Gate charge gate-to-drain			0.3			0.3		nC
Q_{gs}	Gate charge gate-to-source			1.6			1.6		nC
$Q_{g(th)}$	Gate charge at V_{th}			0.6			0.6		nC
Q_{OSS}	Output charge	$V_{DS} = 15$ V, $V_{GS} = 0$ V		5.3			5.3		nC
$t_{d(on)}$	Turnon delay time	$V_{DS} = 15$ V, $V_{GS} = 4.5$ V, $I_{DS} = 4$ A, $R_G = 2$ Ω		2.1			2.1		ns
t_r	Rise time			3.9			3.9		ns
$t_{d(off)}$	Turnoff delay time			9.4			9.4		ns
t_f	Fall time			2.2			2.2		ns
DIODE CHARACTERISTICS									
V_{SD}	Diode forward voltage	$I_{DS} = 4$ A, $V_{GS} = 0$ V		0.80	1.0		0.80	1.0	V
Q_{rr}	Reverse recovery charge	$V_{DS} = 15$ V, $I_F = 4$ A, $di/dt = 300$ A/µs		10			10		nC
t_{rr}	Reverse recovery time			11			11		ns
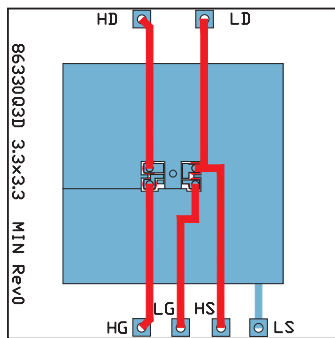
Max $R_{θJA} = 80°C/W$ when mounted on 1 in^2 (6.45 cm^2) of 2-oz (0.071-mm) thick Cu.
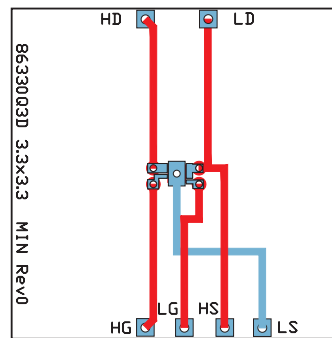
Max $R_{θJA} = 150°C/W$ when mounted on minimum pad area of 2-oz (0.071-mm) thick Cu.

Product Folder Links: *CSD87333Q3D*

5.6 Typical Power Block Device Characteristics

The typical power block system characteristic curves (Figure 1 through Figure 9) are based on measurements made on a PCB design with dimensions of 4 in (W) × 3.5 in (L) × 0.062 in (H) and 6 copper layers of 1-oz copper thickness. See Applications for detailed explanation. T_A = 125°C, unless stated otherwise.
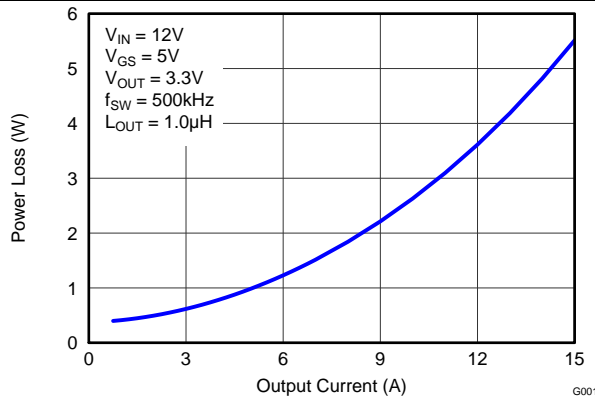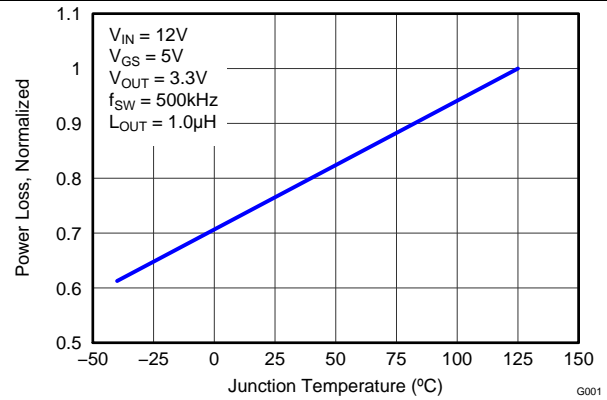

Figure 1. Power Loss vs Output Current

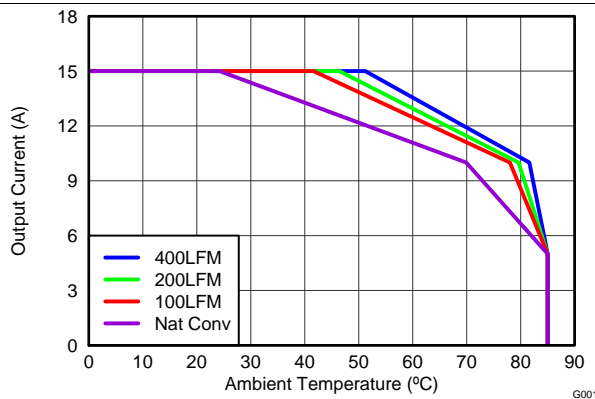

Figure 2. Power Loss vs Temperature
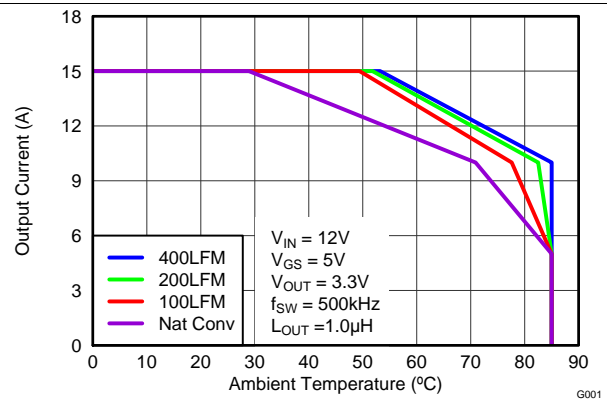

Figure 3. Safe Operating Area – PCB Horizontal Mount
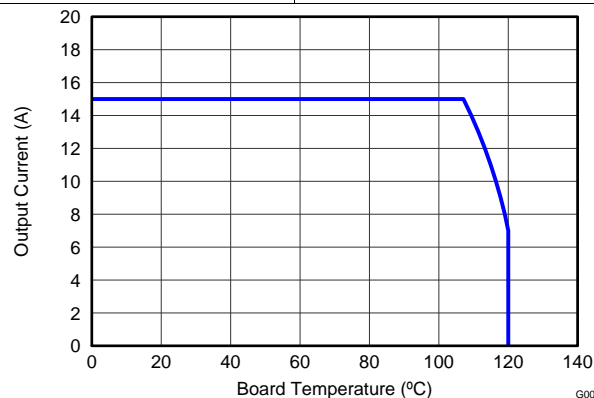

Figure 4. Safe Operating Area – PCB Vertical Mount

Figure 5. Typical Safe Operating Area

Product Folder Links: *CSD87333Q3D*

Typical Power Block Device Characteristics (continued)

The typical power block system characteristic curves (Figure 1 through Figure 9) are based on measurements made on a PCB design with dimensions of 4 in (W) × 3.5 in (L) × 0.062 in (H) and 6 copper layers of 1-oz copper thickness. See Applications for detailed explanation. T_A = 125°C, unless stated otherwise.
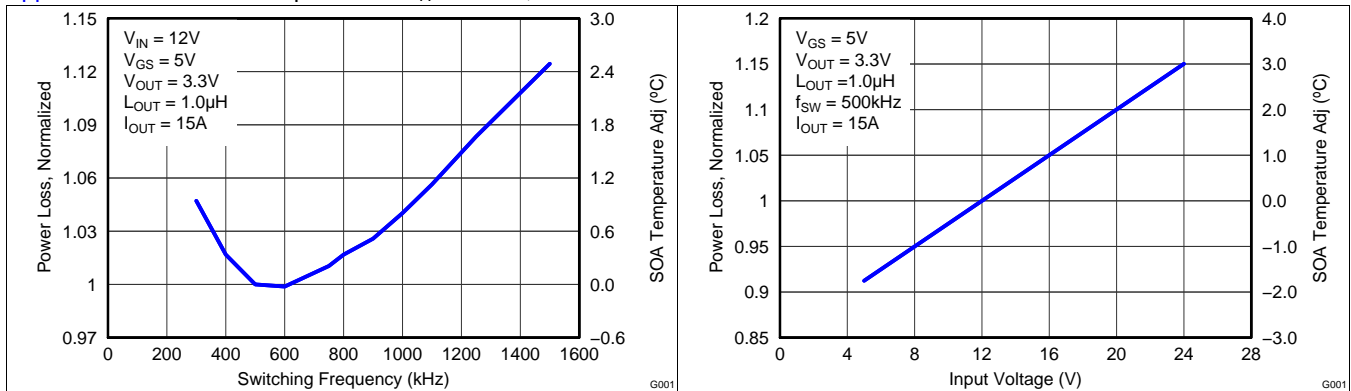

Figure 6. Normalized Power Loss vs Switching Frequency
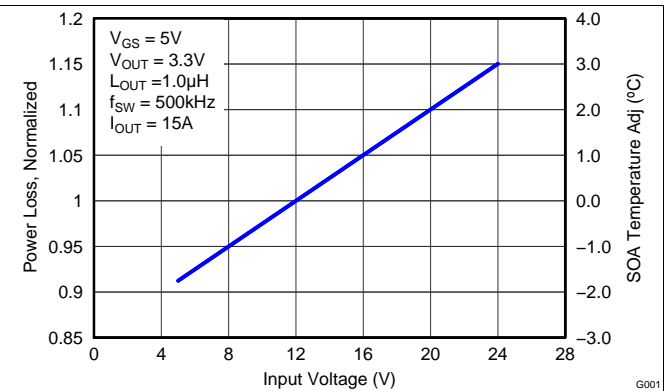

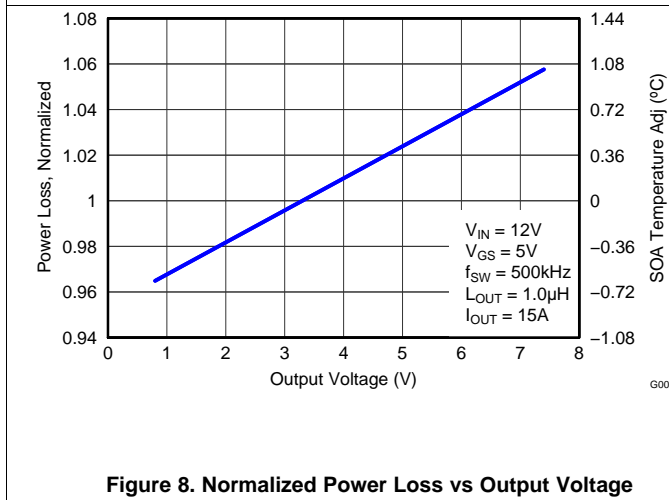**Figure 7. Normalized Power Loss vs Input Voltage**
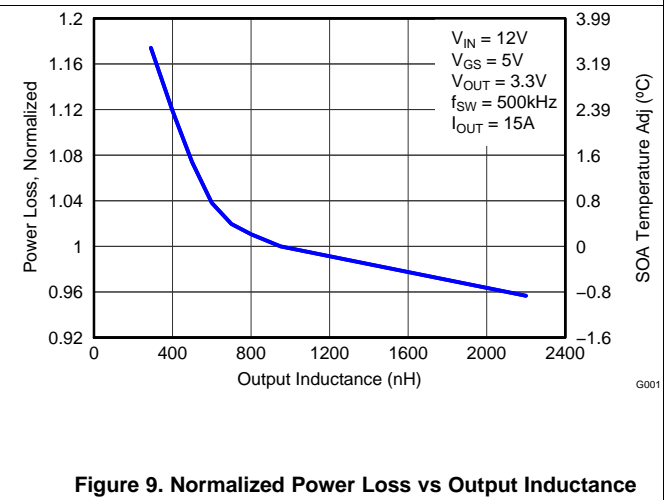

Figure 8. Normalized Power Loss vs Output Voltage

Figure 9. Normalized Power Loss vs Output Inductance

5.7 Typical Power Block MOSFET Characteristics

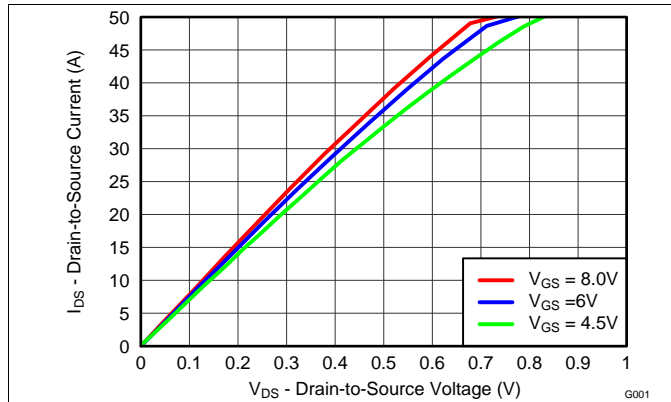T_A = 25°C, unless stated otherwise.

Figure 10. MOSFET Saturation Characteristics
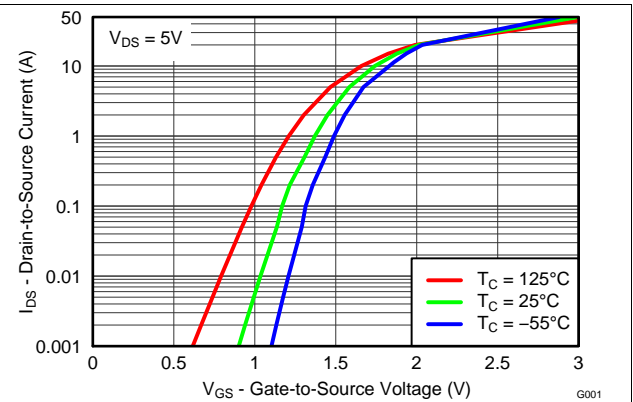
Figure 11. MOSFET Transfer Characteristics

Figure 12. MOSFET Gate Charge

Figure 13. MOSFET Capacitance

Figure 14. MOSFET $V_{GS(th)}$

Figure 15. MOSFET $R_{DS(on)}$ vs V_{GS}

Typical Power Block MOSFET Characteristics (continued)

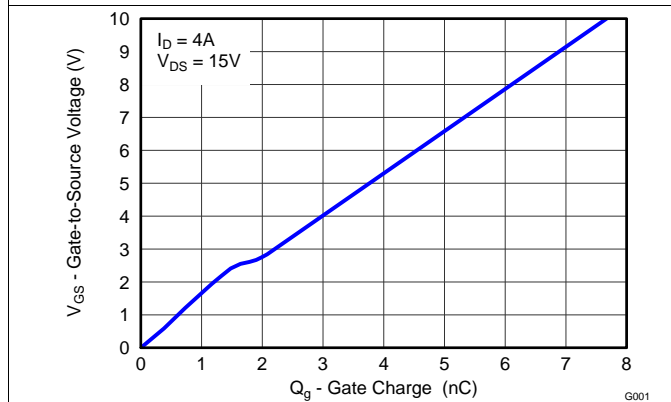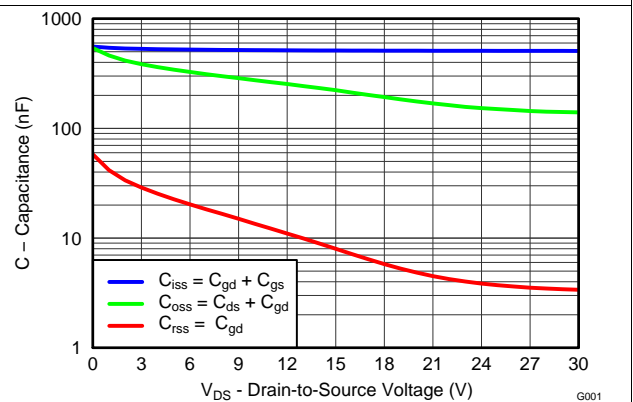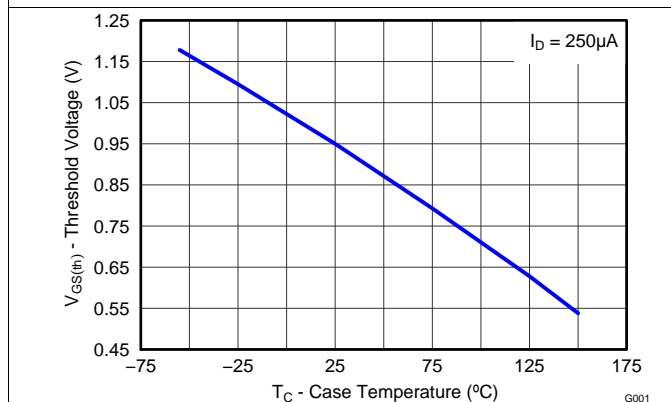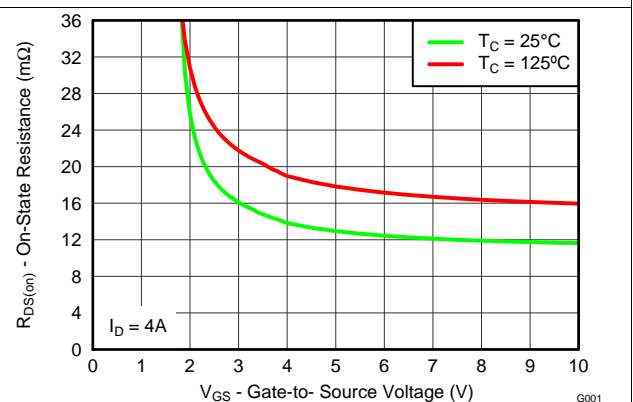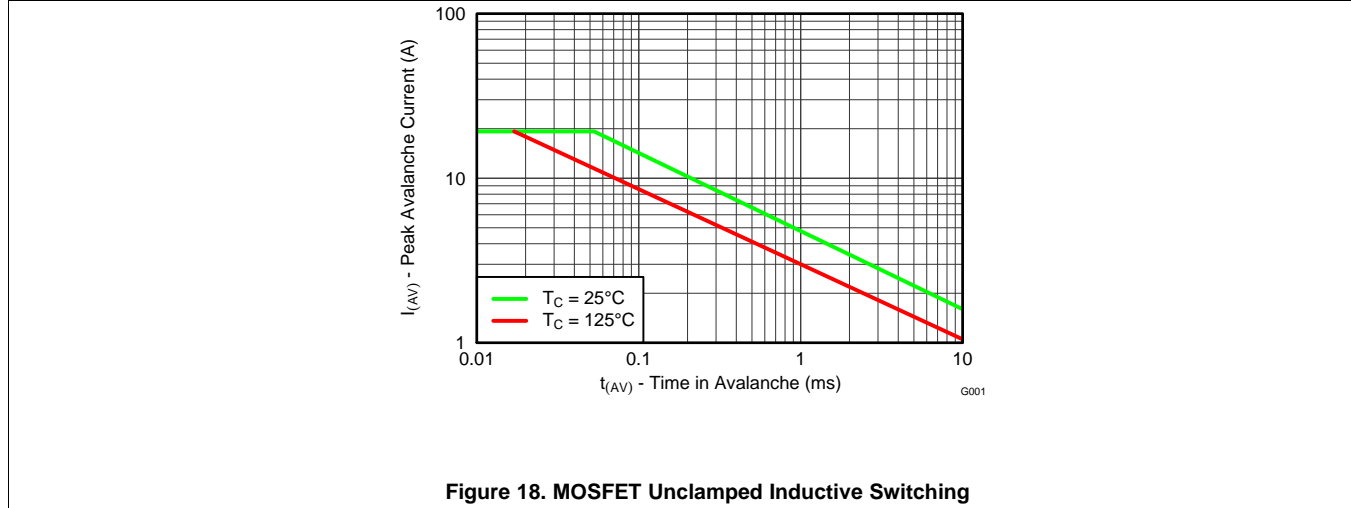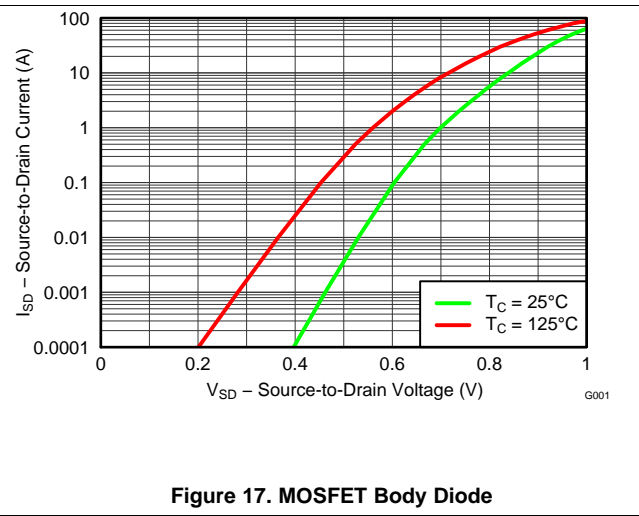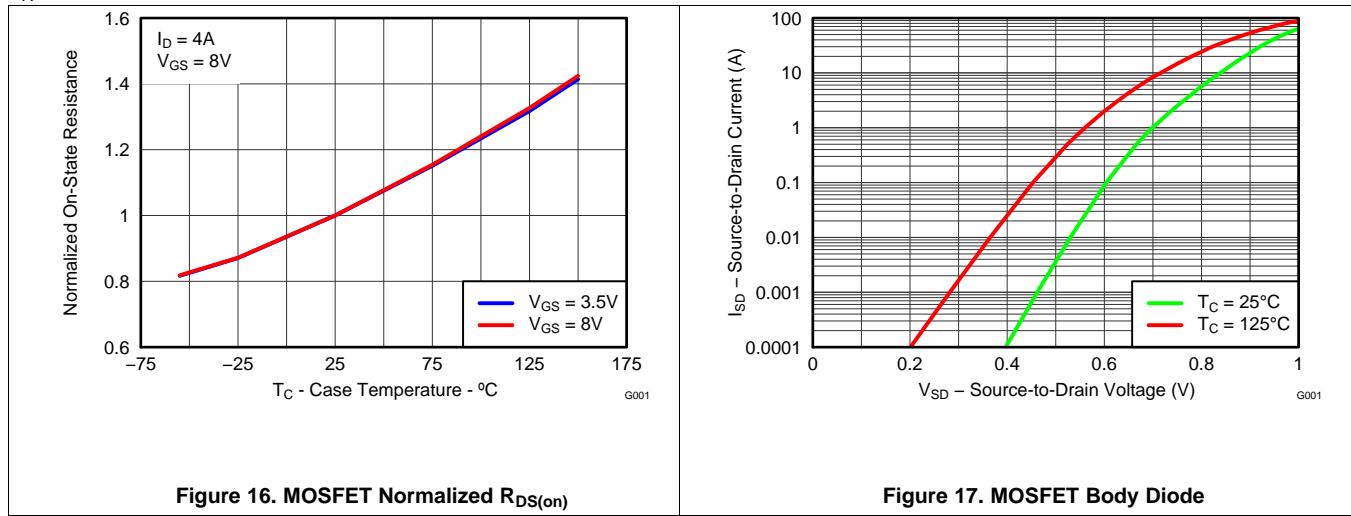$T_A = 25°C$, unless stated otherwise.

Figure 16. MOSFET Normalized $R_{DS(on)}$

Figure 17. MOSFET Body Diode

Figure 18. MOSFET Unclamped Inductive Switching

Product Folder Links: *CSD87333Q3D*

6 Applications

The CSD87333Q3D NexFET power block is an optimized design for synchronous buck applications using 5-V gate drive. The control FET and sync FET silicon are parametrically tuned to yield the lowest power loss and highest system efficiency. As a result, a new rating method is needed which is tailored towards a more systems-centric environment. System-level performance curves such as power loss, SOA, and normalized graphs allow engineers to predict the product performance in the actual application.

6.1 Power Loss Curves

MOSFET centric parameters such as $R_{DS(ON)}$ and Q_{gd} are needed to estimate the loss generated by the devices. In an effort to simplify the design process for engineers, Texas Instruments has provided measured power loss performance curves. Figure 1 plots the power loss of the CSD87333Q3D as a function of load current. This curve is measured by configuring and running the CSD87333Q3D as it would be in the final application (see Figure 19). The measured power loss is the CSD87333Q3D loss and consists of both input conversion loss and gate drive loss. Equation 1 is used to generate the power loss curve.

$$\text{Power loss} = (V_{IN} \times I_{IN}) + (V_{DD} \times I_{DD}) - (V_{SW\_AVG} \times I_{OUT}) \tag{1}$$

The power loss curve in Figure 1 is measured at the maximum recommended junction temperatures of 125°C under isothermal test conditions.

6.2 Safe Operating Area (SOA) Curves

The SOA curves in the CSD87333Q3D data sheet provides guidance on the temperature boundaries within an operating system by incorporating the thermal resistance and system power loss. Figure 3 to Figure 5 outline the temperature and airflow conditions required for a given load current. The area under the curve dictates the safe operating area. All the curves are based on measurements made on a PCB design with dimensions of 4 in (W) × 3.5 in (L) × 0.062 in (T) and 6 copper layers of 1-oz copper thickness.

6.3 Normalized Curves

The normalized curves in the CSD87333Q3D data sheet provides guidance on the power loss and SOA adjustments based on their application specific needs. These curves show how the power loss and SOA boundaries adjust for a given set of system conditions. The primary Y-axis is the normalized change in power loss, and the secondary Y-axis is the change is system temperature required in order to comply with the SOA curve. The change in power loss is a multiplier for the power loss curve and the change in temperature is subtracted from the SOA curve.
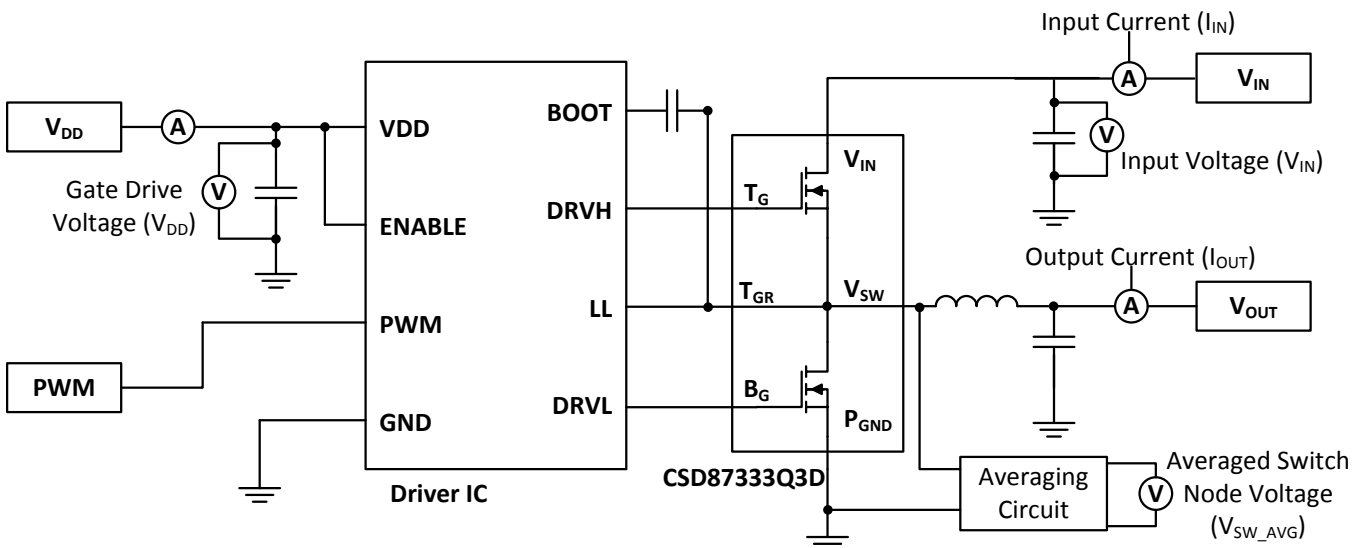

Figure 19. Typical Application

6.4 Calculating Power Loss and SOA

The user can estimate product loss and SOA boundaries by arithmetic means (see Design Example). Though the power loss and SOA curves in this data sheet are taken for a specific set of test conditions, the following procedure outlines the steps the user should take to predict product performance for any set of system conditions.

6.4.1 Design Example

Operating conditions:
- Output current = 10 A
- Input voltage = 20 V
- Output voltage = 1 V
- Switching frequency = 1000 kHz
- Inductor = 0.6 µH

6.4.2 Calculating Power Loss

- Power loss at 10 A = 2.6 W (Figure 1)
- Normalized power loss for input voltage ≈ 1.1 (Figure 7)
- Normalized power loss for output voltage ≈ 0.96 (Figure 8)
- Normalized power loss for switching frequency ≈ 1.04 (Figure 6)
- Normalized power loss for output inductor ≈ 1.03 (Figure 9)
- **Final calculated power loss = 2.6 W × 1.1 × 0.96 × 1.04 × 1.03 ≈ 2.9 W**

6.4.3 Calculating SOA Adjustments

- SOA adjustment for input voltage ≈ 2°C (Figure 7)
- SOA adjustment for output voltage ≈ - 0.2°C (Figure 8)
- SOA adjustment for switching frequency ≈ 0.8°C (Figure 6)
- SOA adjustment for output inductor ≈ 0.8°C (Figure 9)
- **Final calculated SOA adjustment = 2 + (-0.2) + 0.8 + 0.8 ≈ 3.4°C**

In the Design Example, the estimated power loss of the CSD87333Q3D would increase to 2.9 W. In addition, the maximum allowable board or ambient temperature, or both, would have to decrease by 3.4°C. Figure 20 graphically shows how the SOA curve would be adjusted accordingly.
1. Start by drawing a horizontal line from the application current to the SOA curve.
2. Draw a vertical line from the SOA curve intercept down to the board or ambient temperature.
3. Adjust the SOA board or ambient temperature by subtracting the temperature adjustment value.

In the design example, the SOA temperature adjustment yields a reduction in allowable board/ambient temperature of 3.4°C. In the event the adjustment value is a negative number, subtracting the negative number would yield an increase in allowable board or ambient temperature.
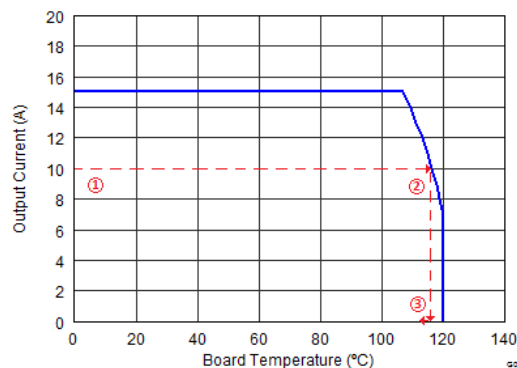

Figure 20. Power Block SOA

Product Folder Links: *CSD87333Q3D*

7 Recommended PCB Design Overview

There are two key system-level parameters that can be addressed with a proper PCB design: electrical and thermal performance. Properly optimizing the PCB layout yields maximum performance in both areas. A brief description on how to address each parameter is provided.

7.1 Electrical Performance

The power block has the ability to switch voltages at rates greater than 10 kV/μs. Special care must be then taken with the PCB layout design and placement of the input capacitors, driver IC, and output inductor.

- The placement of the input capacitors relative to the power block's VIN and PGND pins should have the highest priority during the component placement routine. It is critical to minimize these node lengths. As such, ceramic input capacitors need to be placed as close as possible to the VIN and PGND pins (see Figure 21). The example in Figure 21 uses 6 × 10-μF ceramic capacitors (TDK part number C3216X5R1C106KT or equivalent). Notice there are ceramic capacitors on both sides of the board with an appropriate amount of vias interconnecting both layers. In terms of priority of placement next to the power block, C5, C7, C19, and C8 should follow in order.

- The driver IC should be placed relatively close to the power block gate pins. T_G and B_G should connect to the outputs of the driver IC. The T_{GR} pin serves as the return path of the high-side gate drive circuitry and should be connected to the phase pin of the IC (sometimes called LX, LL, SW, PH, and so forth). The bootstrap capacitor for the driver IC will also connect to this pin.

- The switching node of the output inductor should be placed relatively close to the power block VSW pins. Minimizing the node length between these two components will reduce the PCB conduction losses and actually reduce the switching noise level.[1] In the event the switch node waveform exhibits ringing that reaches undesirable levels, the use of a boost resistor or RC snubber can be an effective way to easily reduce the peak ring level. The recommended boost resistor value will range between 1 Ω to 4.7 Ω depending on the output characteristics of driver IC used in conjunction with the power block. The RC snubber values can range from 0.5 Ω to 2.2 Ω for the R and 330 pF to 2200 pF for the C. Please refer to *Snubber Circuits: Theory, Design and Application* (SLUP100) for more details on how to properly tune the RC snubber values. The RC snubber should be placed as close as possible to the Vsw node and PGND (see Figure 21). [1]

(1) Keong W. Kam, David Pommerenke, "EMI Analysis Methods for Synchronous Buck Converter EMI Root Cause Analysis", University of Missouri – Rolla

7.1 Thermal Performance

The power block has the ability to utilize the GND planes as the primary thermal path. As such, the use of thermal vias is an effective way to pull away heat from the device and into the system board. Concerns of solder voids and manufacturability problems can be addressed by the use of three basic tactics to minimize the amount of solder attach that will wick down the via barrel:

- Intentionally space out the vias from each other to avoid a cluster of holes in a given area.
- Use the smallest drill size allowed in your design. The example in Figure 21 uses vias with a 10-mil drill hole and a 16-mil capture pad.
- Tent the opposite side of the via with solder-mask.

The number and drill size of the thermal vias should align with the end user's PCB design rules and manufacturing capabilities.
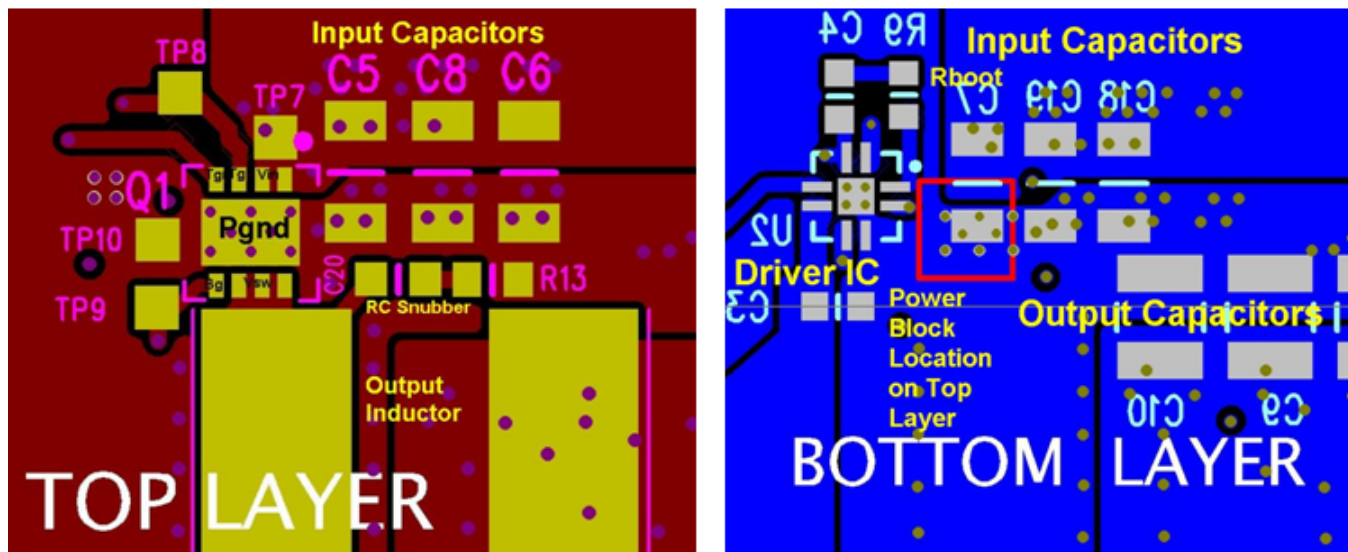

Figure 21. Recommended PCB Layout (Top Down)

Product Folder Links: *CSD87333Q3D*

8 Device and Documentation Support

8.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

8.3 Trademarks

NexFET, E2E are trademarks of Texas Instruments.
All other trademarks are the property of their respective owners.

8.4 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

8.5 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

9 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

9.1 Q3D Package Dimensions

Top View

Side View

Bottom View

Exposed tie clips may vary
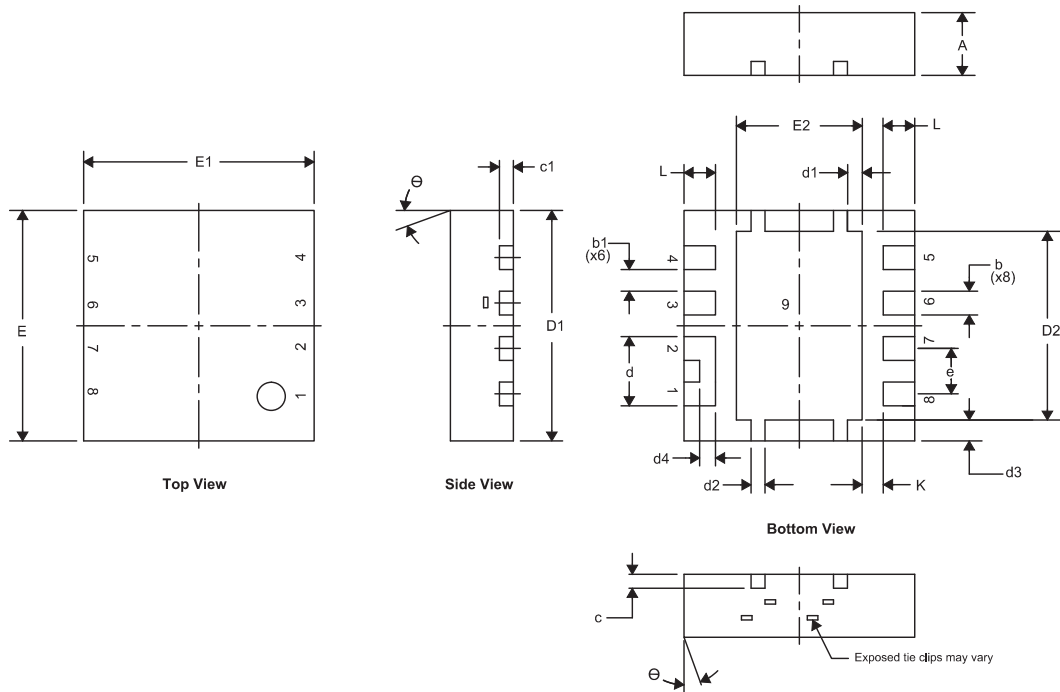
DIM	MILLIMETERS		INCHES	
	MIN	**MAX**	**MIN**	**MAX**
A	0.850	1.050	0.033	0.041
b	0.280	0.400	0.011	0.016
b1	0.310 NOM		0.012 NOM	
c	0.150	0.250	0.006	0.010
c1	0.150	0.250	0.006	0.010
d	0.940	1.040	0.037	0.041
d1	0.160	0.260	0.006	0.010
d2	0.150	0.250	0.006	0.010
d3	0.250	0.350	0.010	0.014
d4	0.175	0.275	0.007	0.011
D1	3.200	3.400	0.126	0.134
D2	2.650	2.750	0.104	0.108
E	3.200	3.400	0.126	0.134
E1	3.200	3.400	0.126	0.134
E2	1.750	1.850	0.069	0.073
e	0.650 TYP		0.026 TYP	
L	0.400	0.500	0.016	0.020
θ	0.000	—	—	—
K	0.300 TYP		0.012 TYP	

Product Folder Links: *CSD87333Q3D*

9.2 Pinout Configuration

Table 1. Pinout Configuration

POSITION	DESIGNATION
Pin 1	V_{IN}
Pin 2	V_{IN}
Pin 3	T_G
Pin 4	T_{GR}
Pin 5	B_G
Pin 6	V_{SW}
Pin 7	V_{SW}
Pin 8	V_{SW}
Pin 9	P_{GND}

Product Folder Links: *CSD87333Q3D*

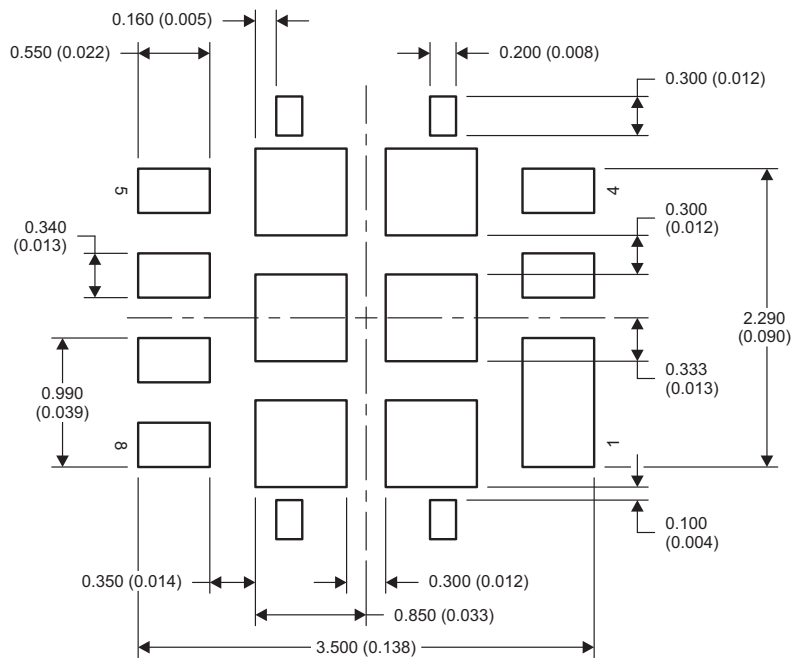## 9.3 Land Pattern Recommendation
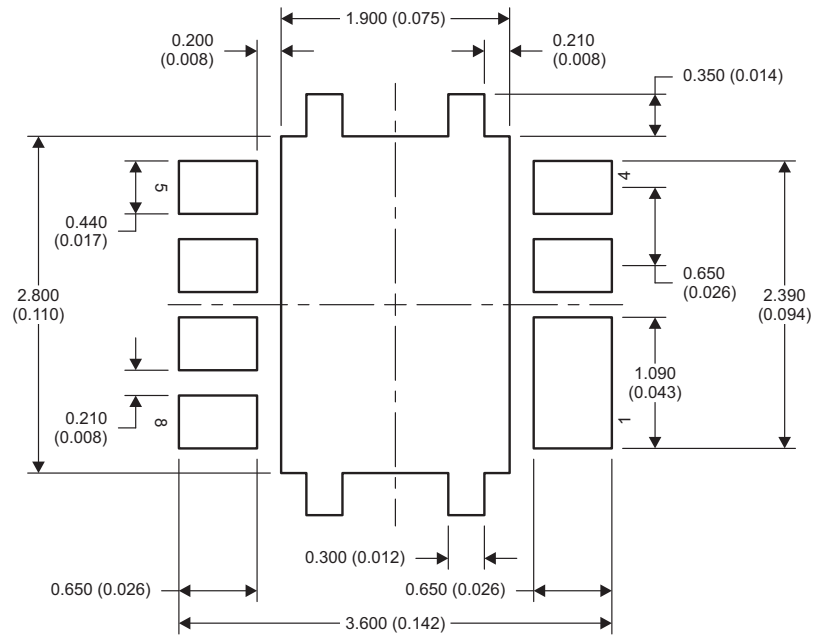
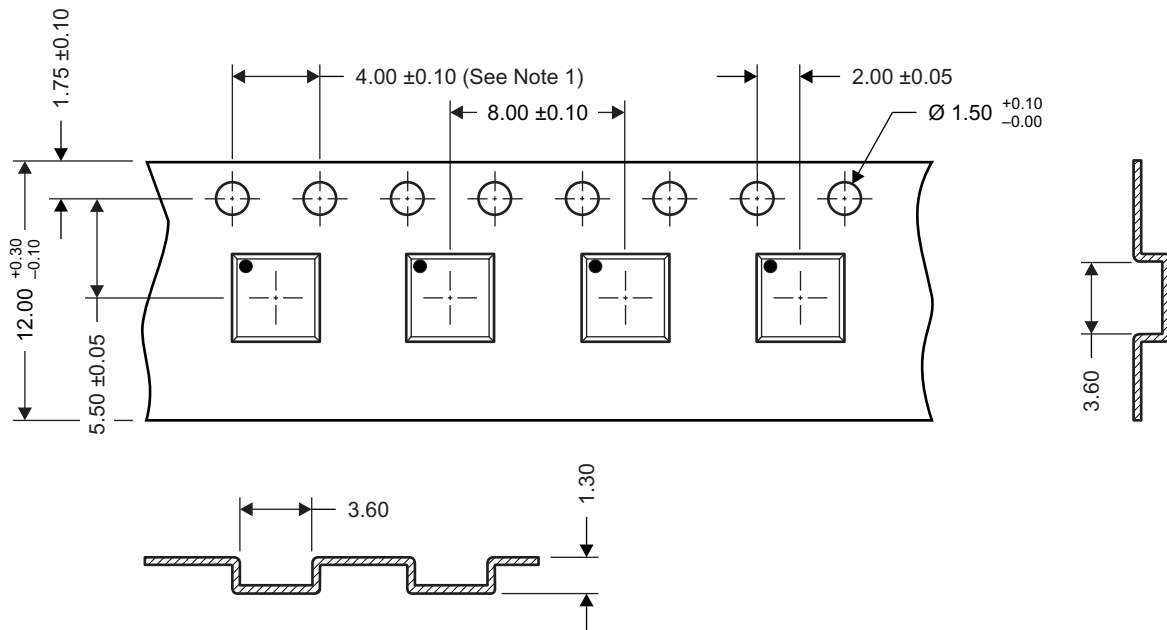NOTE: Dimensions are in mm (in).

9.4 Stencil Recommendation

NOTE: Dimensions are in mm (in).

For recommended circuit layout for PCB designs, see *Reducing Ringing Through PCB Layout Techniques* (SLPA005).

9.5 Q3D Tape and Reel Information

M0144-01

NOTES: 1. 10-sprocket hole-pitch cumulative tolerance ± 0.2.

2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm.

3. Material: black static-dissipative polystyrene.

4. All dimensions are in mm, unless otherwise specified.

5. Thickness: 0.3 ± 0.05 mm.

6. MSL1 260°C (IR and convection) PbF reflow compatible.

![Texas Instruments logo]

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD87333Q3D	ACTIVE	VSON-CLIP	DPB	8	2500	Pb-Free (RoHS Exempt)	CU NIPDAU	CU SN	Level-1-260C-UNLIM	-55 to 150	87333D	Samples
CSD87333Q3DT	ACTIVE	VSON-CLIP	DPB	8	250	Pb-Free (RoHS Exempt)	CU NIPDAU	CU SN	Level-1-260C-UNLIM	-55 to 150	87333D	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD87333Q3D	VSON-CLIP	DPB	8	2500	330.0	12.4	3.6	3.6	1.2	8.0	12.0	Q1
CSD87333Q3D	VSON-CLIP	DPB	8	2500	330.0	12.4	3.6	3.6	1.2	8.0	12.0	Q1
CSD87333Q3DT	VSON-CLIP	DPB	8	250	330.0	15.4	3.6	3.6	1.2	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD87333Q3D	VSON-CLIP	DPB	8	2500	367.0	367.0	35.0
CSD87333Q3D	VSON-CLIP	DPB	8	2500	336.6	336.6	41.3
CSD87333Q3DT	VSON-CLIP	DPB	8	250	333.2	345.9	28.6

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